

Notice of References Cited	Application/Control No. 10/772,651	Applicant(s)/Patent Under Reexamination SHIN ET AL.	
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*	B	US-6,569,709	05-2003	Derderian, James M.	438/109
*	C	US-6,215,182	04-2001	Ozawa et al.	257/723
*	D	US-6,099,783	08-2000	Scranton et al.	264/272.11
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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